

SN54LS297, SN74LS297 DIGITAL PHASE-LOCKED-LOOP FILTERS

SDLS155 – JANUARY 1981 – REVISED MARCH 1988

- Digital Design Avoids Analog Compensation Errors
- Easily Cascadable for Higher Order Loops
- Useful Frequency from DC to:
50 MHz Typical (K Clock)
35 MHz Typical (I/D Clock)

description

The SN54LS297 and SN74LS297 devices are designed to provide a simple, cost-effective solution to high-accuracy, digital, phase-locked-loop applications. These devices contain all the necessary circuits, with the exception of the divide-by-N counter, to build first order phase-locked loops as described in Figure 1.

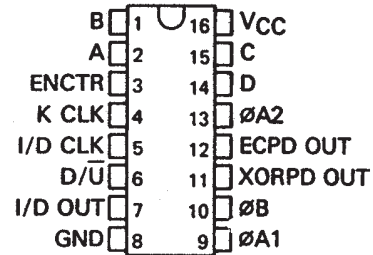
Both exclusive-OR (XORPD) and edge-controlled (ECPD) phase detectors are provided for maximum flexibility.

Proper partitioning of the loop function, with many of the building blocks external to the package, makes it easy for the designer to incorporate ripple cancellation or to cascade to higher order phase-locked loops.

The length of the up/down K counter is digitally programmable according to the K counter function table. With A, B, C, and D all low, the K counter is disabled. With A high and B, C, and D low, the K counter is only three stages long, which widens the bandwidth or capture range and shortens the lock time of the loop. When A, B, C, and D are all programmed high, the K counter becomes seventeen stages long, which narrows the bandwidth or capture range and lengthens the lock time. Real-time control of loop bandwidth by manipulating the A through D inputs can maximize the overall performance of the digital phase-locked loop.

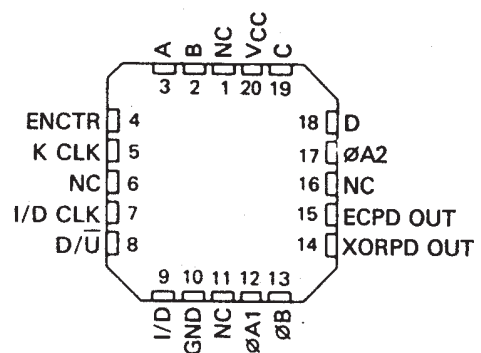
SN54LS297 . . . J OR W PACKAGE
SN74LS297 . . . N PACKAGE

(TOP VIEW)



SN54LS297 . . . FK PACKAGE

(TOP VIEW)



NC-No internal connection

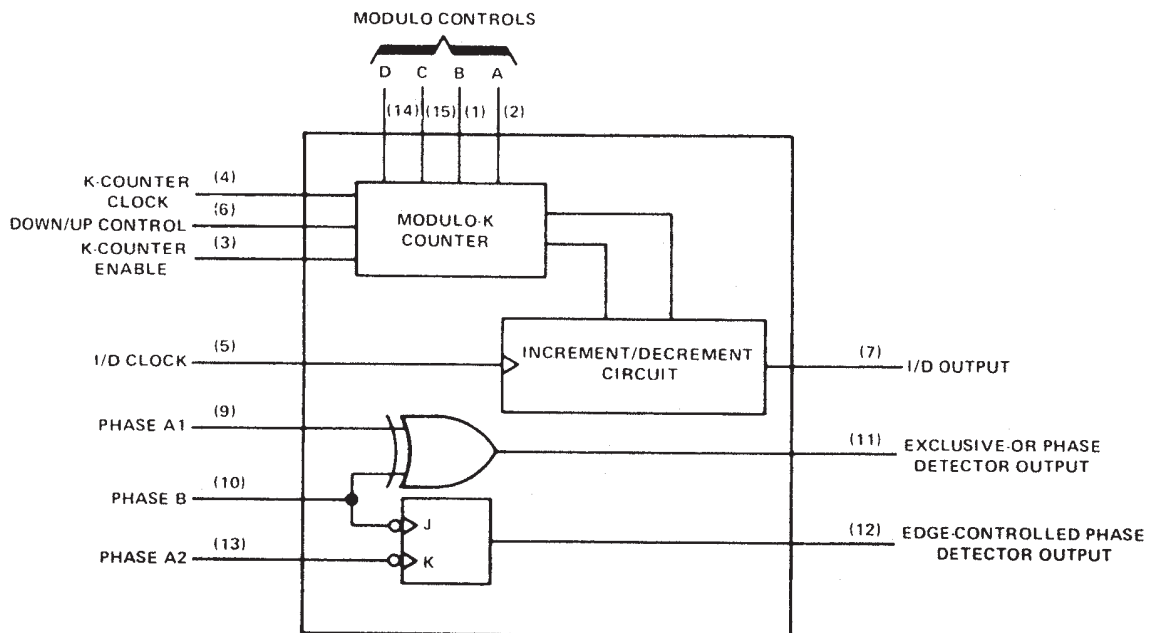


FIGURE 1—SIMPLIFIED BLOCK DIAGRAM

Pin numbers shown are for J, N and W packages.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

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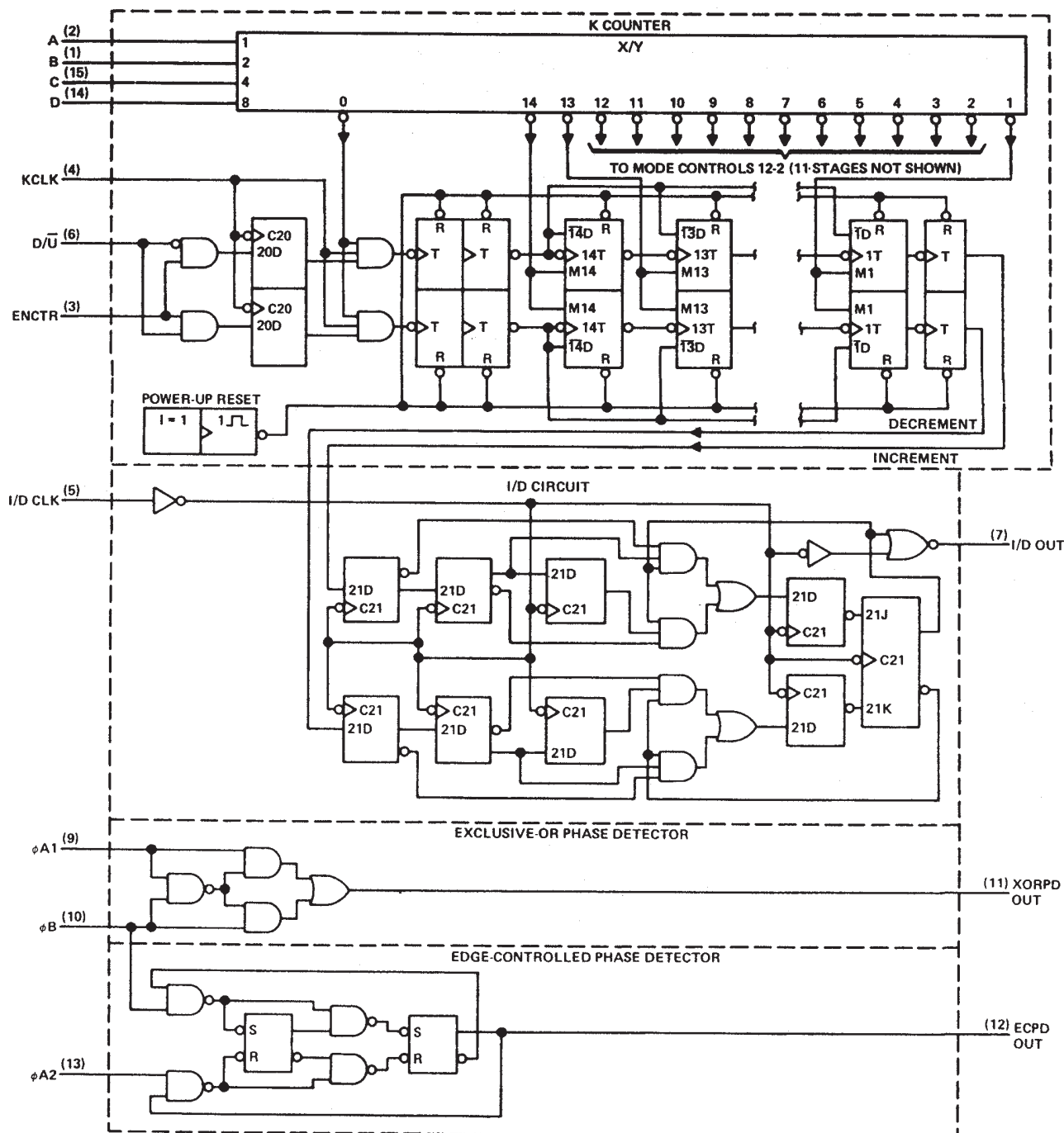
SN54LS297, SN74LS297 DIGITAL PHASE-LOCKED-LOOP FILTERS

SDLS155 – JANUARY 1981 – REVISED MARCH 1988

description (continued)

The 'LS297 can perform the classic first-order phase-locked loop function without using analog components. The accuracy of the digital phase-locked loop (DPLL) is not affected by V_{CC} and temperature variations, but depends solely on accuracies of the K clock, I/D clock, and loop propagation delays. The I/D clock frequency and the divide-by-N modulus will determine the center frequency of the DPLL. The center frequency is defined by the relationship $f_c = I/D \text{ Clock}/2N \text{ (Hz)}$.

logic diagram (positive logic)



Pin numbers shown are for J, N, and W packages.



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SN54LS297, SN74LS297 DIGITAL PHASE-LOCKED-LOOP FILTERS

SDLS155 – JANUARY 1981 – REVISED MARCH 1988

**K COUNTER FUNCTION TABLE
(DIGITAL CONTROL)**

D	C	B	A	MODULO (K)
L	L	L	L	Inhibited
L	L	L	H	2 ³
L	L	H	L	2 ⁴
L	L	H	H	2 ⁵
L	H	L	L	2 ⁶
L	H	L	H	2 ⁷
L	H	H	L	2 ⁸
L	H	H	H	2 ⁹
H	L	L	L	2 ¹⁰
H	L	L	H	2 ¹¹
H	L	H	L	2 ¹²
H	L	H	H	2 ¹³
H	H	L	L	2 ¹⁴
H	H	L	H	2 ¹⁵
H	H	H	L	2 ¹⁶
H	H	H	H	2 ¹⁷

**FUNCTION TABLE
EXCLUSIVE-OR PHASE DETECTOR**

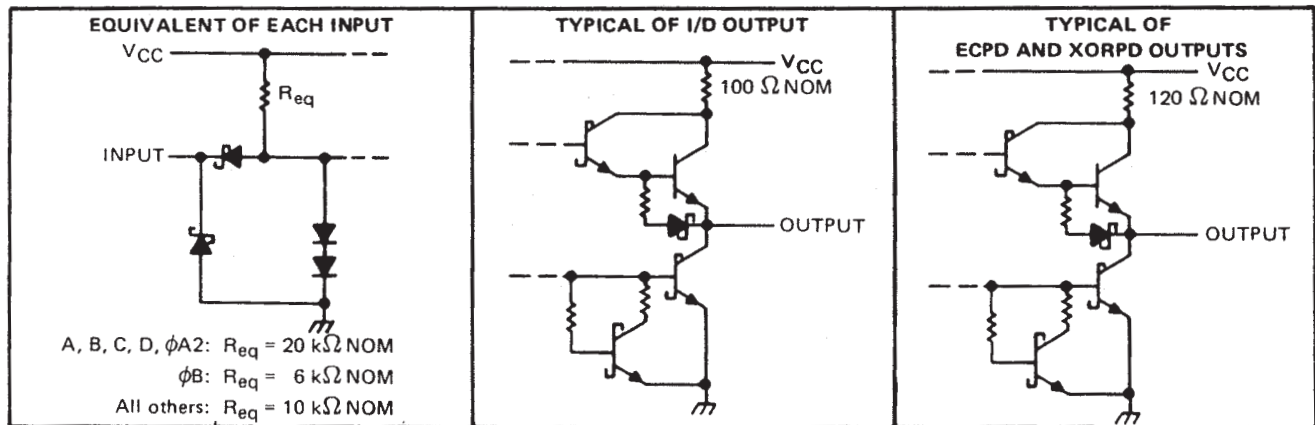
$\phi A1$	ϕB	XORPD OUT
L	L	L
L	H	H
H	L	H
H	H	L

**FUNCTION TABLE
EDGE-CONTROLLED PHASE DETECTOR**

$\phi A2$	ϕB	ECPD OUT
H or L	↓	H
↓	H or L	L
H or L	↑	No change
↑	H or L	No change

H = steady-state high level
L = steady-state low level
↓ = transition from high to low
↑ = transition from low to high

schematics of inputs and outputs



operation

The phase detector generates an error signal waveform that, at zero phase error, is a 50% duty cycle square wave. At the limits of linear operation, the phase detector output will be either high or low all of the time, depending on the direction of the phase error ($\phi_{in} - \phi_{out}$). Within these limits, the phase detector output varies linearly with the input phase error according to the gain k_d , which is expressed in terms of phase detector output per cycle of phase error. The phase detector output can be defined to vary between ± 1 according to the relation:

$$\text{PD Output} = \frac{\% \text{ high} - \% \text{ low}}{100} \quad (1)$$

The output of the phase detector will be $k_d \phi_e$, where the phase error $\phi_e = \phi_{in} - \phi_{out}$.

SN54LS297, SN74LS297 DIGITAL PHASE-LOCKED-LOOP FILTERS

SDLS155 – JANUARY 1981 – REVISED MARCH 1988

Exclusive-OR phase detectors (XORPD) and edge-controlled phase detectors (ECPD) are commonly used digital types. The ECPD is more complex than the XORPD logic function, but can be described generally as a circuit that changes states on one of the transitions of its inputs. k_d for an XORPD is 4 because its output remains high (PD output = 1) for a phase error of 1/4 cycle. Similarly, k_d for the ECPD is 2 since its output remains high for a phase error of 1/2 cycle. The type of phase detector will determine the zero-phase-error point, i.e., the phase separation of the phase detector inputs for ϕ_e defined to be zero. For the basic DPLL system of Figure 2, $\phi_e = 0$ when the phase detector output is a square wave. The XORPD inputs are 1/4 cycle out of phase for zero phase error. For the ECPD, $\phi_e = 0$ when the inputs are 1/2 cycle out of phase.

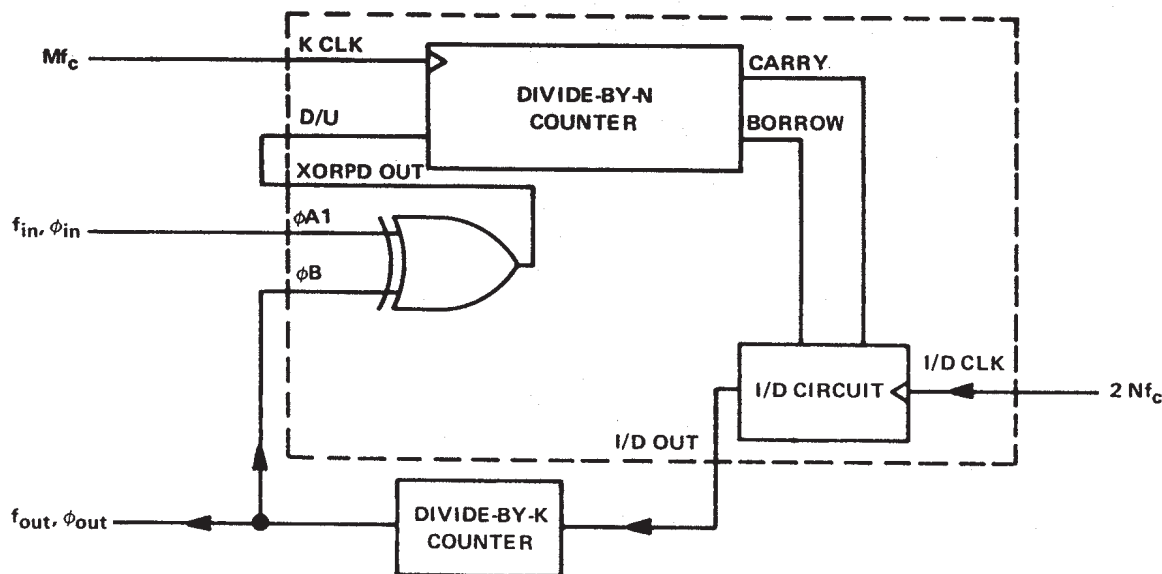


FIGURE 2—DPLL USING EXCLUSIVE-OR PHASE DETECTION

The phase detector output controls the up/down input to the K counter. The counter is clocked by input frequency Mf_c , which is a multiple M of the loop center frequency f_c . When the K counter recycles up, it generates a carry pulse. Recycling while counting down generates a borrow pulse. If the carry and borrow outputs are conceptually combined into one output that is positive for a carry and negative for a borrow, and if the K counter is considered as a frequency divider with the ratio Mf_c/K , the output of the K counter will equal the input frequency multiplied by the division ratio. Thus the output from the K counter is $(k_d \phi_e Mf_c)/K$.

The carry and borrow pulses go to the increment/decrement (I/D) circuit, which, in the absence of any carry or borrow pulse, has an output that is 1/2 of the input clock I/D CLK. The input clock is just a multiple, $2N$, of the loop center frequency. In response to a carry or borrow pulse, the I/D circuit will either add or delete a pulse at I/D OUT. Thus the output of the I/D circuit will be $Nf_c + (k_d \phi_e Mf_c)/2K$.

The output of the N counter (or the output of the phase-locked loop) is thus:

$$f_o = f_c + (k_d \phi_e Mf_c)/2KN$$

If this result is compared to the equation for a first-order analog phase-locked loop, the digital equivalent of the gain of the VCO is just $Mf_c/2KN$ or f_c/K for $M = 2N$.

Thus the simple first-order phase-locked loop with an adjustable K counter is the equivalent of an analog phase-locked loop with a programmable VCO gain.



Supply voltage, V _{CC} (see Note 1)	7 V
Input voltage	7 V
Operating free-air temperature range: SN54LS297	− 55° C to 125° C
SN74LS297	0° C to 70° C
Storage temperature range	− 65° C to 150° C

			SN54LS297			SN74LS297			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
I _{OH}	High-level output current	I/D OUT			− 1.2			− 1.2	mA
		EXOR, ECPD			− 400			− 400	μA
I _{OL}	Low-level output current	I/D OUT			12			24	mA
		XOR, ECPD			4			8	mA
f _{clock}	Clock frequency	K Clock	0		32	0		32	MHz
		I/D Clock	0		16	0		16	MHz
t _w	Width of clock input pulse	K Clock	16			16			ns
		I/D Clock	33			33			ns
t _{su, to K}	Setup time to K Clock t	U/D, ENCTR	30			30			ns
t _h	Hold time from K Clock t	U/D, ENCTR	0			0			ns
T _A	Operating free-air temperature		− 55		125	0		70	°C

SN54LS297, SN74LS297

DIGITAL PHASE-LOCKED-LOOP FILTERS

SDLS155 – JANUARY 1981 – REVISED MARCH 1988

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	SN54LS297			SN74LS297			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V _{IH}	High-level input voltage		2			2			V
V _{IL}	Low-level input voltage				0.7			0.8	V
V _{IK}	Input clamp voltage	V _{CC} = MIN, I _I = -18 mA			-1.5			-1.5	V
V _{OH}	High-level output voltage	I/D OUT	V _{CC} = MIN, V _{IH} = 2 V, I _{OH} = MAX			2.4			V
	Others	V _{IL} = V _{IL} max	I _{OH} = MAX			2.5			
V _{OL}	Low-level output voltage	I/D OUT	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = V _{IL} max	I _{OL} = 12 mA	0.25	0.4	0.25	0.4	V
				I _{OL} = 24 mA			0.35	0.5	
		Others		I _{OL} = 4 mA	0.25	0.4	0.25	0.4	
				I _{OL} = 8 mA			0.35	0.5	
I _I	Input current at maximum input voltage		V _{CC} = MAX, V _I = 7 V			0.1			mA
I _{IH}	High-level input current	U/D, EN, ϕA1	V _{CC} = MAX, V _I = 2.7 V			40			μA
		ϕB				60			
		All others				20			
I _{IL}	Low-level input current	U/D, EN, ϕA1	V _{CC} = MAX, V _I = 0.4 V			-0.8			mA
		ϕB				-1.2			
		All others				-0.4			
I _{OS}	Short-circuit output current §	I/D OUT	V _{CC} = MAX			-30			mA
		Others				-20			
I _{CC}	Supply current		V _{CC} = MAX, All inputs grounded, All outputs open			75 120			mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are of V_{CC} = 5 V, T_A = 25°C.

§ Not more than one output should be shorted at a time and the duration of the short-circuit should not exceed one second.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER¶	FROM (INPUT)		TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{max}	KCLK		I/D OUT	R _L = 667 Ω , C _L = 45 pF, See Note 2	32	50		MHz
	I/D CLK		I/D OUT		16	35		
t _{PLH}	I/D CLK ↑		I/D OUT			15	25	ns
t _{PHL}	I/D CLK ↑		I/D OUT			22	35	ns
t _{PLH}	ϕ A1 or ϕ B	Other input low	XOR OUT	R _L = 2 k Ω , C _L = 45 pF, See Note 2		10	15	ns
	ϕ A1 or ϕ B	Other input high	XOR OUT			17	25	
t _{PHL}	ϕ A1 or ϕ B	Other input low	XOR OUT			15	25	ns
	ϕ A1 or ϕ B	Other input high	XOR OUT			17	25	
t _{PLH}	ϕ B ↓		ECPD OUT			20	30	ns
t _{PHL}	ϕ A2 ↓		ECPD OUT			20	30	ns

¶ t_{PLH} = propagation delay time, low-to-high-level output

t_{PHL} = propagation delay time, high-to-low-level output

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LS297N	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	0 to 70	SN74LS297N	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



PINS ** DIM	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



4040049/E 12/2002

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 -  Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 -  The 20 pin end lead shoulder width is a vendor option, either half or full width.

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